Search Notes



Application/Control No.

Applicant(s)/Patent under Reexamination

10/721,075

Examiner

Applicant(s)/Patent under Reexamination

TANAKA, KOICHIRO

Art Unit

1725

M. Alexandra Elve

SEARCHED					
Class	Subclass	Date	Examiner		
219	121.76	6/3/2005	MAE		
219	121.78	6/3/2005	MAE		
219	121.81	6/3/2005	MAE		
219	121.85	6/3/2005	MAE		
219	121.65	6/3/2 005	MAE		
219	121.66	6/3/2005	MAE		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
219	121.76	6/23/2005	MAE		
219	121.78	6/23/2005	MAE		
219	121.85	6/23/2005	MAE		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
US OCR, US PAT, US PG, Derwent, JPO, EPO (see attached search strategy)	6/3/2005	MAE
Inventor search (PALM)	6/3/2005	MAE